

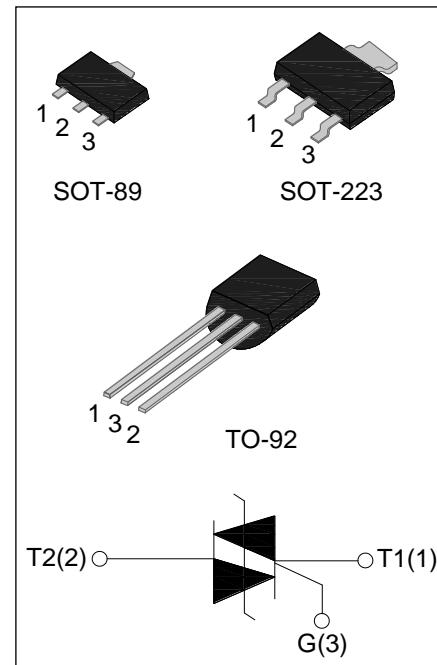


ACJT1 Series 1A TRIACs

Rev.3.0

DESCRIPTION:

ACJT1 series triacs with high ability to withstand the shock loading of large current provide high dv/dt rate with strong resistance to electromagnetic interference. They are especially recommended for use on inductive load and serious electromagnetic interference place.



MAIN FEATURES

Symbol	Value	Unit
$I_T(\text{RMS})$	1	A
$V_{\text{DRM}}/V_{\text{RRM}}$	1000	V
I_{GT}	≤ 5 or ≤ 10	mA

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Storage junction temperature range	T_{stg}	-40-150	°C
Operating junction temperature range	T_j	-40-125	°C
Repetitive peak off-state voltage($T_j=25^\circ\text{C}$)	V_{DRM}	1000	V
Repetitive peak reverse voltage($T_j=25^\circ\text{C}$)	V_{RRM}	1000	V
Non repetitive surge peak Off-state voltage	V_{DSM}	$V_{\text{DRM}}+100$	V
Non repetitive peak reverse voltage	V_{RSM}	$V_{\text{RRM}}+100$	V
RMS on-state current	$I_{\text{T(RMS)}}$	1	A
($T_c=70^\circ\text{C}$)		1	A
Non repetitive surge peak on-state current (full cycle, $F=50\text{Hz}$)	I_{TSM}	10	A
I^2t value for fusing ($t_p=10\text{ms}$)	I^2t	1.12	A^2s
Rate of rise of on-state current ($I_G=2\times I_{\text{GT}}$)	dI_T/dt	50	$\text{A}/\mu\text{s}$
Peak gate current	I_{GM}	1	A
Average gate power dissipation	$P_{\text{G(AV)}}$	0.2	W

Peak gate power	P_{GM}	1	W
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ELECTRICAL CHARACTERISTICS ($T_j=25^\circ C$ unless otherwise specified)

Symbol	Test Condition	Quadrant		Value		Unit
				ACJT105	ACJT110	
I_{GT}	$V_D=12V$ $R_L=33\Omega$	I - II - III	MAX	5	10	mA
V_{GT}		I - II - III	MAX	1.4	1.5	V
V_{GD}	$V_D=V_{DRM}$ $T_j=125^\circ C$ $R_L=3.3K\Omega$	I - II - III	MIN	0.2		V
I_L	$I_G=1.2I_{GT}$	I - III	MAX	15	25	mA
		II		25	35	
I_H	$I_T=100mA$		MAX	10	20	mA
dV/dt	$V_D=2/3V_{DRM}$ Gate Open $T_j=125^\circ C$		MIN	400	600	V/ μ s

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
V_{TM}	$I_{TM}=1.4A$	$t_p=380\mu s$	$T_j=25^\circ C$	1.5
I_{DRM}	$V_D=V_{DRM}$	$V_R=V_{RRM}$	$T_j=25^\circ C$	10
I_{RRM}			$T_j=125^\circ C$	0.5

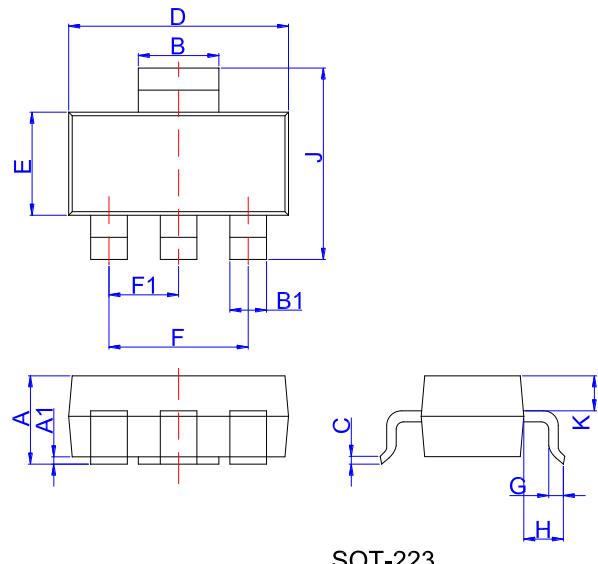
THERMAL RESISTANCES

Symbol	Parameter		Value	Unit
$R_{th(j-c)}$	junction to case(AC)	TO-92	60	°C/W
		SOT-223	31	
		SOT-89	44	

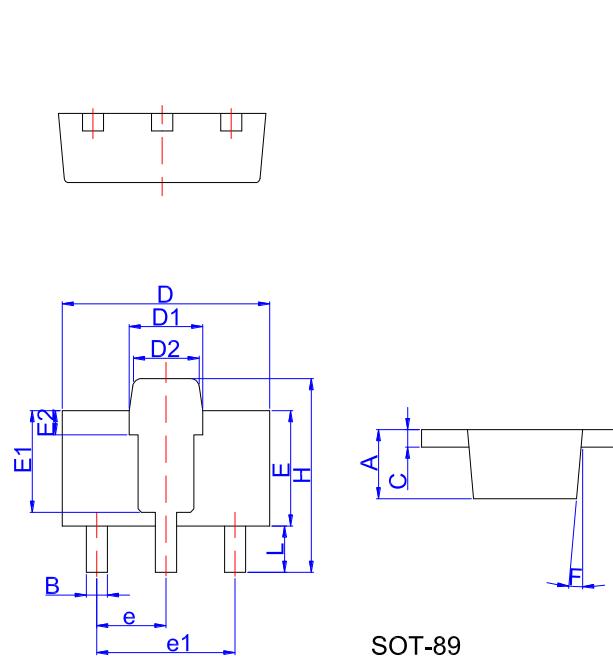
ORDERING INFORMATION

AC	J	T	1	05	-10	U
AC switch						V:SOT-223 U:TO-92 N:SOT-89
JieJie Microelectronics Co.,Ltd		Triacs				10:V _{DRM} / V _{RRM} ≥ 1000V
						05: I _{GTO-3} ≤ 5mA
						10: I _{GTO-3} ≤ 10mA

PACKAGE MECHANICAL DATA

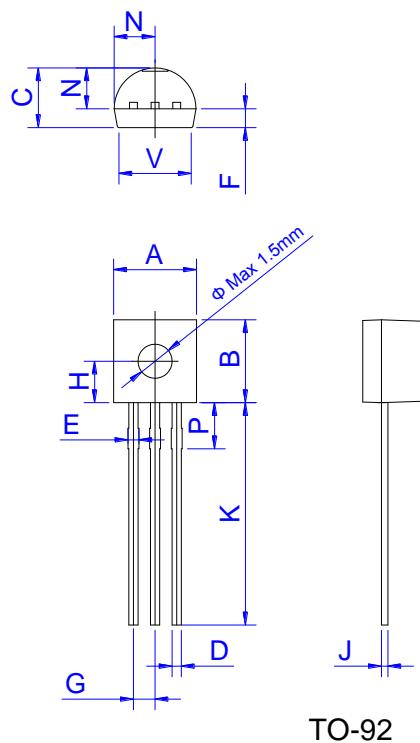


Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	1.5	1.6	1.8	0.059	0.063	0.071
A1	0	0.06	0.10	0	0.002	0.004
B	2.9	3.0	3.1	0.114	0.118	0.122
B1	0.6	0.7	0.8	0.024	0.028	0.031
C	0.22	0.26	0.32	0.009	0.010	0.013
D	6.3	6.5	6.7	0.248	0.256	0.264
E	3.3	3.5	3.7	0.130	0.138	0.146
F		4.6			0.181	
F1		2.3			0.091	
G	0.7	0.9	1.1	0.028	0.035	0.043
H	1.5	1.75	2.0	0.059	0.069	0.079
J	6.7	7.0	7.3	0.264	0.276	0.287
K	0.8	0.9	1.0	0.031	0.035	0.039



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	1.40		1.60	0.055		0.063
B	0.35		0.52	0.014		0.020
C	0.35		0.46	0.014		0.018
D	4.30		4.70	0.169		0.185
D1	1.50		1.70	0.059		0.067
D2	1.30		1.50	0.051		0.059
E	2.30		2.70	0.091		0.106
E1		2.20			0.087	
E2		0.52			0.020	
e		1.50			0.059	
e1		3.00			0.118	
F		5°			5°	
H	3.94		4.0	0.155		0.157
L	0.80		1.20	0.031		0.047

PACKAGE MECHANICAL DATA



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.45		5.20	0.175		0.205
B	4.32		5.33	0.170		0.210
C	3.18		4.19	0.125		0.165
D	0.407		0.533	0.016		0.021
E	0.60		0.80	0.024		0.031
F	-	1.1	-	-	0.043	-
G	-	1.27	-	-	0.050	-
H	-	2.30	-	-	0.091	-
J	0.36		0.50	0.014		0.020
K	12.70		15.0	0.500		0.591
N	2.04		2.66	0.080		0.105
P	1.86		2.06	0.073		0.081
V	-		4.3	-		0.169

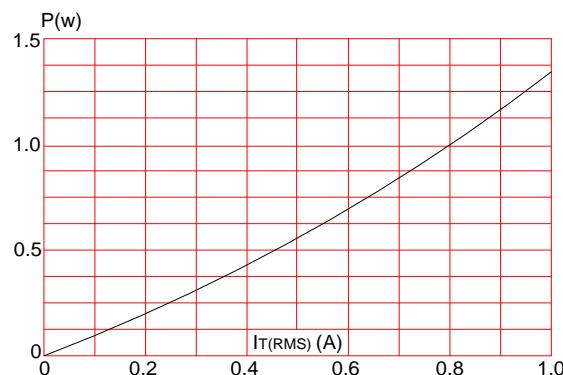
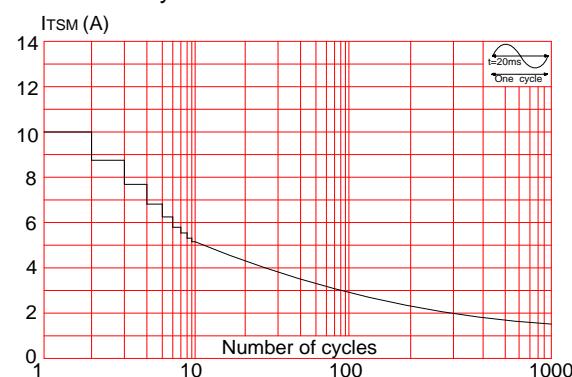
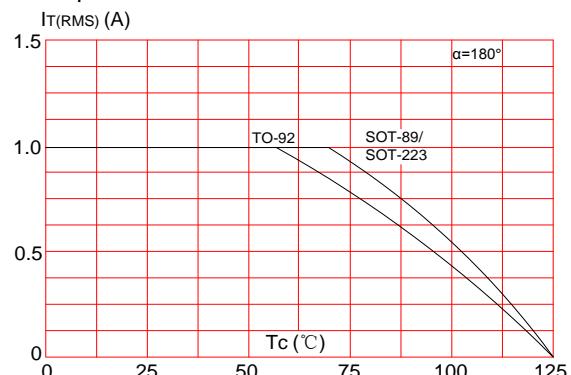
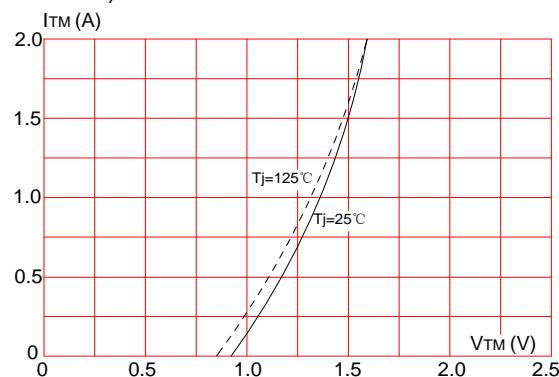
FIG.1 Maximum power dissipation versus RMS on-state current**FIG.3:** Surge peak on-state current versus number of cycles**FIG.2:** RMS on-state current versus case temperature**FIG.4:** On-state characteristics (maximum values)



FIG.5: Relative variations of gate trigger current versus junction temperature

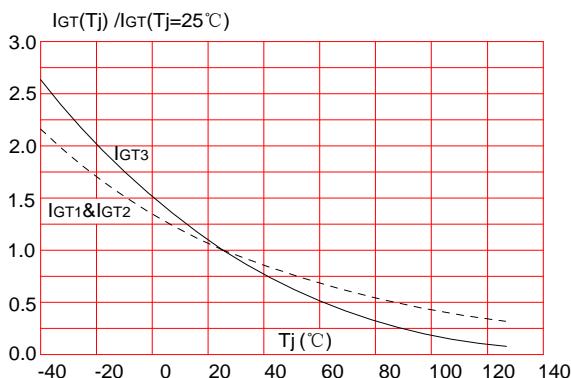
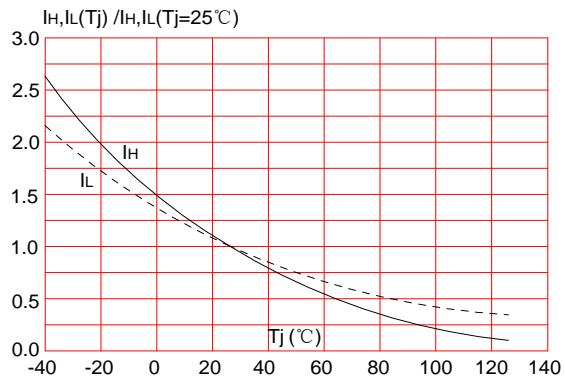


FIG.6: Relative variations of holding current, latching current versus junction temperature



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